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Notice of Allowability	Application No.	Applicant(s)
	10/595,991	SMITH ET AL.
	Examiner	Art Unit
	Quyen P. Leung	2874
The MAILING DATE of this communication apperature All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this ap ) or other appropriate communication IGHTS. This application is subject to	plication. If not included
1. This communication is responsive to		
2. ☑ The allowed claim(s) is/are <u>1-13</u> .		
3.	e been received. e been received in Application No cuments have been received in this of this communication to file a reply dENT of this application.  itted. Note the attached EXAMINER' es reason(s) why the oath or declarate the submitted. con's Patent Drawing Review ( PTO-S as Amendment / Comment or in the O as Amendment / Comment or in the O as After a coording to 37 CFR 1.121(c) sit of BIOLOGICAL MATERIAL materials.	national stage application from the complying with the requirements  S AMENDMENT or NOTICE OF tion is deficient.  948) attached  ffice action of the back) of all the submitted. Note the
Attachment(s)  I. ☑ Notice of References Cited (PTO-892)  I. ☑ Notice of Draftperson's Patent Drawing Review (PTO-948)  Information Disclosure Statements (PTO/SB/08), Paper No./Mail Date 20060524  Examiner's Comment Regarding Requirement for Deposit of Biological Material	5. Notice of Informal Pa 6. Interview Summary ( Paper No./Mail Date 7. Examiner's Amendm 8. Examiner's Statemer 9. Other	(PTO-413),
		Quyen Leung Primary Patent Examiner Group Art Unit 2874

Application/Control Number:

10/595,991 Art Unit: 2874

## **REASONS FOR ALLOWANCE**

The following is an examiner's statement of reasons for allowance: 🗡

The claims are allowed because the cited prior art do not teach or fairly suggest the combination of method steps as claimed. While each of the references 1, 3, 4, 7, and 16 from the information disclosure statement filed 5/24/2006 teaches domain inversion by electric field poling of a sample of lithium niobate, they fail to teach or fairly suggest applying a layer of metallic zinc to a z-face of lithium niobate for forming a waveguiding structure. While references 10, 17 each teaches a layer of metallic zinc to a z-face of lithium niobate, they fail to teach or fairly suggest using a sample of lithium niobate whose domain inversion is by electric field poling.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Quyen P. Leung whose telephone number is (571) 272-8188. The examiner can normally be reached on normally M-F, 6:15 am - 2:45 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Rodney Bovernick can be reached on (571) 272-2344. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Quyen Leung/ Quyen Leung Primary Patent Examiner Group Art Unit 2874

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